

Data Sheet March 1999 File Number 1893.3

# 3.5A, 400V, 1.000 Ohm, N-Channel Power MOSFET

This N-Channel enhancement mode silicon gate power field effect transistor is an advanced power MOSFET designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA17414.

### **Ordering Information**

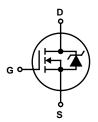
PART NUMBER	PACKAGE	BRAND		
IRFF330	TO-205AF	IRFF330		

NOTE: When ordering, include the entire part number.

#### **Features**

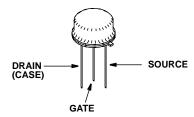
- 3.5A, 400V
- $r_{DS(ON)} = 1.000\Omega$
- Single Pulse Avalanche Energy Rated
- · SOA is Power Dissipation Limited
- · Nanosecond Switching Speeds
- · Linear Transfer Characteristics
- · High Input Impedance
- · Related Literature
  - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

# Symbol



# Packaging

#### **JEDEC TO-205AF**



# **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

	IRFF330	UNITS
Drain to Source Voltage (Note 1)V <sub>DS</sub>	400	V
Drain to Gate Voltage ( $R_{GS} = 20k\Omega$ ) (Note 1)	400	V
Continuous Drain Current	3.5	Α
Pulsed Drain Current (Note 3)	14	Α
Gate to Source VoltageV <sub>GS</sub>	±20	V
Maximum Power Dissipation	25	W
Linear Derating Factor	0.2	W/oC
Single Pulse Avalanche Energy Rating (Note 4)	300	mJ
Operating and Storage Temperature Range	-55 to 150	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10sT <sub>L</sub>	300	°C
Package Body for 10s, See Techbrief 334	260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1.  $T_J = 25^{\circ}C$  to  $125^{\circ}C$ .

# **Electrical Specifications** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA (Figure 10)			-	-	V
Gate to Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250\mu A$			-	4.0	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = Rated BV <sub>DSS</sub> , V <sub>GS</sub> = 0V		-	-	25	μΑ
		$V_{DS} = 0.8 \text{ x Rated BV}_{DSS}, V_{GS} = 0V,$	$T_{J} = 125^{\circ}C$	=	-	250	μΑ
On-State Drain Current (Note 2)	I <sub>D(ON)</sub>	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}, V_{GS} = 10$	OV (Figure 7)	3.5	-	-	Α
Gate to Source Leakage Forward	I <sub>GSS</sub>	$V_{GS} = \pm 20V$		-	-	±100	nA
Drain to Source On Resistance (Note 2)	r <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 2.0A (Figures 8, 9)		=	0.8	1.000	Ω
Forward Transconductance (Note 2)	9fs	V <sub>DS</sub> = 10V, I <sub>D</sub> = 3.3A (Figure 12)		2.9	3.5	-	S
Turn-On Delay Time	t <sub>d(ON)</sub>	$\begin{split} &I_D\approx 3.5\text{A, R}_G=9.1\Omega,V_{GS}=10\text{V, R}_L=49\Omega\\ &V_{DD}=175\text{V (Figures 17, 18) MOSFET Switching}\\ &\text{Times are Essentially Independent of Operating}\\ &\text{Temperature} \end{split}$		-	-	30	ns
Rise Time	t <sub>r</sub>			-	-	35	ns
Turn-Off Delay Time	t <sub>d</sub> (OFF)			-	-	55	ns
Fall Time	t <sub>f</sub>			-	-	35	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q <sub>g(TOT)</sub>	$\begin{array}{l} V_{GS}=10\text{V, I}_D=3.5\text{A, I}_{G(REF)}=1.5\text{mA,} \\ V_{DS}=0.8\text{V x Rated BV}_{DSS} \text{ (Figures 14, 19, 20)} \\ \text{Gate Charge is Essentially Independent of} \\ \text{Operating Temperature} \end{array}$		-	18	30	nC
Gate to Source Charge	Q <sub>gs</sub>			=	11	-	nC
Gate to Drain "Miller" Charge	Q <sub>gd</sub>			-	7.0	-	nC
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1.0MHz (Figure 11)		-	700	-	pF
Output Capacitance	C <sub>OSS</sub>			-	150	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				40	-	pF
Internal Drain Inductance	L <sub>D</sub>	Lead, 5mm (0.2in) from Symbol Sho	Modified MOSFET Symbol Showing the Internal Device Inductances	-	5.0	-	nH
Internal Source Inductance	LS	Measured from the Source Lead, 5mm (0.2in) from Header to Source Bonding Pad		-	15	-	nH
Junction to Case	$R_{\theta JC}$	,		-	-	5.0	°C/W
Junction to Ambient	$R_{\theta JA}$	ree Air Operation		-	-	175	°C/W

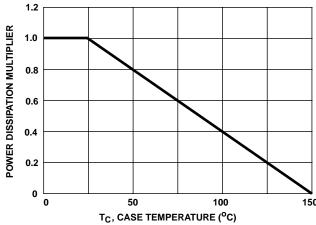
### **Source to Drain Diode Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I <sub>SD</sub>	Modified MOSFET	РΫ	-	-	3.5	Α
Pulse Source to Drain Current (Note 3)	I <sub>SDM</sub>	Symbol Showing the Integral Reverse P-N Junction Rectifier.	G OF THE STATE OF	-	-	14	А
Source to Drain Diode Voltage (Note 2)	V <sub>SD</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = 3.5A$ , $V_{GS} = 0V$ (Figure 13)		-	-	1.6	V
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 150^{\circ}C$ , $I_{SD} = 3.5A$ , $dI_{SD}/dt = 100A/\mu s$		-	600	-	ns
Reverse Recovered Charge	Q <sub>RR</sub>	$T_J = 150^{\circ}C$ , $I_{SD} = 3.5A$ , $dI_{SD}/dt = 100A/\mu s$		-	4.0	-	μС

#### NOTES:

- 2. Pulse test: pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2\%$ .
- 3. Repetitive Rating: pulse width limited by Max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4.  $V_{DD}$  = 50V, start  $T_J$  = 25°C, L = 42.85mH,  $R_G$  = 25 $\Omega$ , peak  $I_{AS}$  = 3.5A (Figures 14,15).

# Typical Performance Curves Unless Otherwise Specified



150 25 50 75 100 125 150 T<sub>C</sub>, CASE TEMPERATURE (°C)

FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

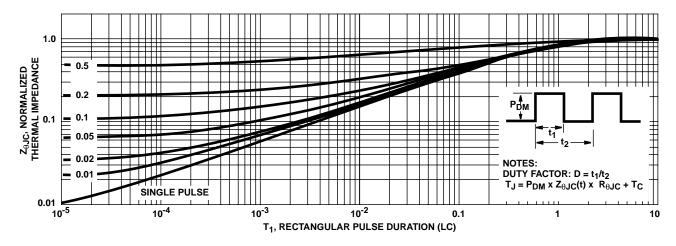


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

### Typical Performance Curves Unless Otherwise Specified (Continued)

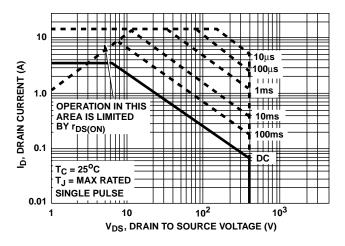


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

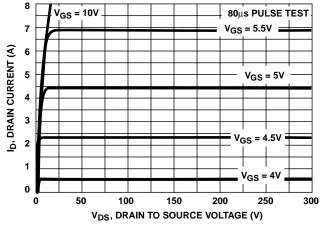


FIGURE 5. OUTPUT CHARACTERISTICS

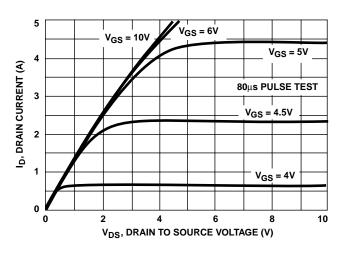


FIGURE 6. SATURATION CHARACTERISTICS

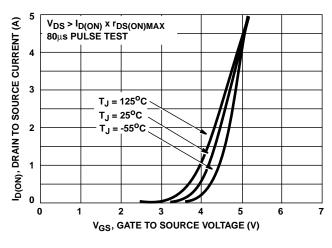
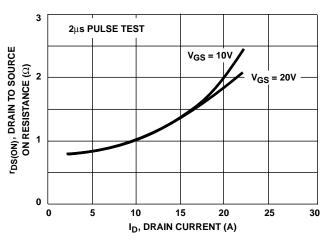


FIGURE 7. TRANSFER CHARACTERISTICS



NOTE: Heating effect of 2µs pulse is minimal.

FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

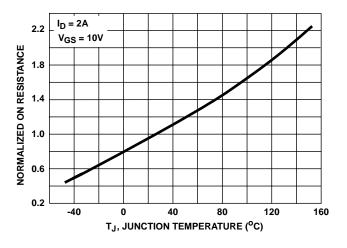


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

## Typical Performance Curves Unless Otherwise Specified (Continued)

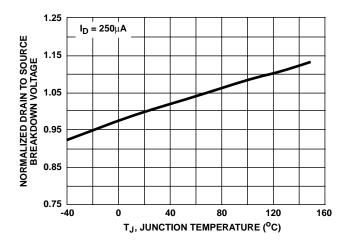


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

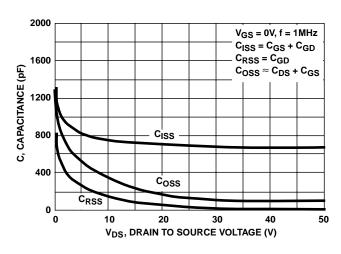


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

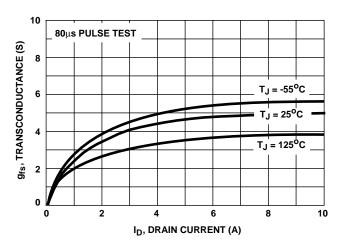


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

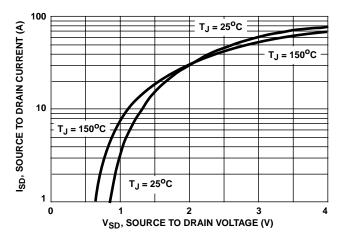


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

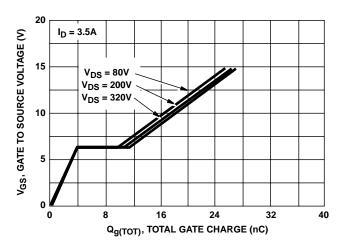


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

## Test Circuits and Waveforms

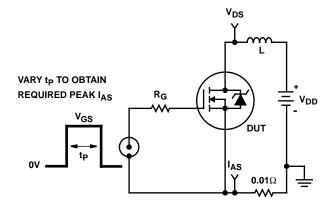


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

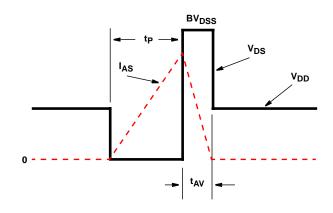


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

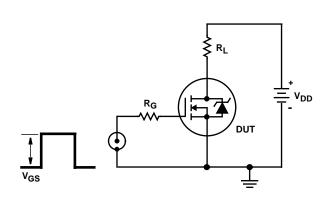


FIGURE 17. SWITCHING TIME TEST CIRCUIT

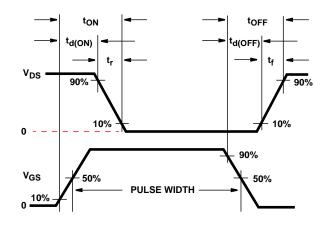


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

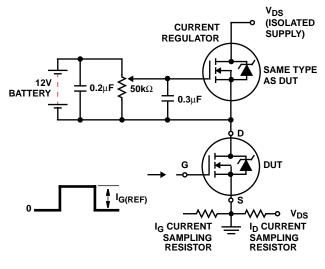


FIGURE 19. GATE CHARGE TEST CIRCUIT

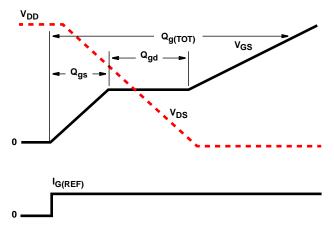


FIGURE 20. GATE CHARGE WAVEFORMS

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